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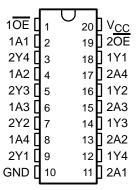
- Typical V_{OLP} (Output Ground Bounce)
 1 V at V_{CC} = 5 V, T_A = 25°C
- High-Drive Outputs (–32-mA I_{OH}, 64-mA I_{OL})
- I_{off} Supports Partial-Power-Down Mode Operation
- Latch-Up Performance Exceeds 500 mA Per JEDEC Standard JESD-17
- ESD Protection Exceeds JESD 22
 - 2000-V Human-Body Model (A114-A)
 - 200-V Machine Model (A115-A)

description

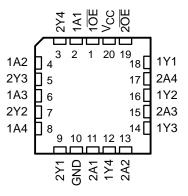
These octal buffers and line drivers are designed specifically to improve both the performance and density of 3-state memory address drivers, clock drivers, and bus-oriented receivers and transmitters. Together with the SN54ABT241, SN74ABT241A, SN54ABT244, and SN74ABT244A, these devices provide the choice of selected combinations of inverting and noninverting outputs, symmetrical active-low output-enable (\overline{OE}) inputs, and complementary OE and \overline{OE} inputs.

The SN54ABT240 and SN74ABT240A are organized as two 4-bit buffers/line drivers with separate \overline{OE} inputs. When \overline{OE} is low, the devices pass inverted data from the A inputs to the Y outputs. When \overline{OE} is high, the outputs are in the high-impedance state.

SN54ABT240 . . . J OR W PACKAGE SN74ABT240A . . . DB, DW, N, NS, OR PW PACKAGE (TOP VIEW)



SN54ABT240 . . . FK PACKAGE (TOP VIEW)



ORDERING INFORMATION

TA	PACKAGE [†]		ORDERABLE PART NUMBER	TOP-SIDE MARKING
	PDIP – N Tube		SN74ABT240AN	SN74ABT240AN
−40°C to 85°C	SOIC - DW	Tube	SN74ABT240ADW	ABT240A
	301C - DW	Tape and reel	SN74ABT240ADWR	AB1240A
	SOP - NS	Tape and reel	SN74ABT240ANSR	ABT240A
	SSOP – DB	Tape and reel	SN74ABT240ADBR	AB240A
	TSSOP – PW	Tape and reel	SN74ABT240APWR	AB240A
CDIP – J Tube		Tube	SNJ54ABT240J	SNJ54ABT240J
–55°C to 125°C	CFP – W	Tube	SNJ54ABT240W	SNJ54ABT240W
	LCCC – FK	Tube	SNJ54ABT240FK	SNJ54ABT240FK

[†] Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



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description (continued)

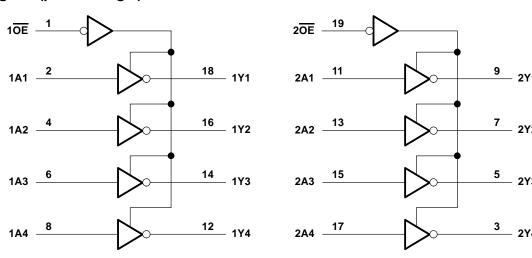
This device is fully specified for partial-power-down applications using Ioff. The Ioff circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.

To ensure the high-impedance state during power up or power down, \overline{OE} should be tied to V_{CC} through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

FUNCTION TABLE (each buffer)

INP	JTS	OUTPUT
OE	Α	Y
L	Н	L
L	L	Н
Н	Χ	Z

logic diagram (positive logic)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage range, V _{CC}	0.5 V to 7 V
Input voltage range, V _I (see Note 1)	0.5 V to 7 V
Voltage range applied to any output in the high-impedance or powe	r-off state, V _O –0.5 V to 5.5 V
Current into any output in the low state, IO: SN54ABT240	96 mA
SN74ABT240A	128 mA
Input clamp current, I _{IK} (V _I < 0)	–18 mA
Output clamp current, I _{OK} (V _O < 0)	
Package thermal impedance, θ_{JA} (see Note 2): DB package	
DW package	58°C/W
N package	69°C/W
NS package	60°C/W
PW package	83°C/W
Storage temperature range, T _{sta}	—65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

^{2.} The package thermal impedance is calculated in accordance with JESD 51-7.



recommended operating conditions (see Note 3)

			SN54ABT240		SN74ABT240A		UNIT
			MIN	MAX	MIN	MAX	UNIT
Vcc	V _{CC} Supply voltage		4.5	5.5	4.5	5.5	V
VIH	High-level input voltage		2		2		V
V _{IL} Low-level input voltage			0.8		0.8	V	
V _I Input voltage		0	VCC	0	VCC	V	
loh	OH High-level output current					-32	mA
loL	IOL Low-level output current			48		64	mA
Δt/Δν	Input transition rise or fall rate	Outputs enabled		5		5	ns/V
TA	Operating free-air temperature	ree-air temperature		125	-40	85	°C

NOTE 3: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		Т	T _A = 25°C		SN54ABT240		SN74ABT240A			
PARAI	MEIER	I EST COND	IIIONS	MIN	TYP [†]	MAX	MIN	MAX	MIN	MAX	UNIT	
VIK		V _{CC} = 4.5 V,	I _I = -18 mA			-1.2		-1.2		-1.2	V	
		$V_{CC} = 4.5 \text{ V},$	I _{OH} = -3 mA	2.5			2.5		2.5			
\/ -		V _{CC} = 5 V,	I _{OH} = -3 mA	3			3		3		V	
VOH		V _{CC} = 4.5 V	$I_{OH} = -24 \text{ mA}$	2			2				V	
		VCC = 4.5 V	I _{OH} = -32 mA	2*					2			
\/o:		V _{CC} = 4.5 V	I _{OL} = 48 mA			0.55		0.55			V	
VOL		VCC = 4.5 V	I _{OL} = 64 mA			0.55*				0.55	V	
V_{hys}					100						mV	
lį		$V_{CC} = 5.5 \text{ V},$	$V_I = V_{CC}$ or GND			±1		±1		±1	μΑ	
lozh		$V_{CC} = 5.5 \text{ V},$	$V_0 = 2.7 \text{ V}$			10		10		10	μΑ	
lozL		$V_{CC} = 5.5 \text{ V},$	$V_0 = 0.5 V$			-10		-10		-10	μΑ	
l _{off}		$V_{CC} = 0$,	V_I or $V_O \le 4.5 \text{ V}$			±100				±100	μΑ	
ICEX		$V_{CC} = 5.5 \text{ V}, V_{O} = 5.5 \text{ V}$	Outputs high			50		50		50	μΑ	
1O [‡]		$V_{CC} = 5.5 \text{ V},$	V _O = 2.5 V	-50	-100	-180	-50	-180	-50	-180	mA	
			Outputs high		1	250		250		250	μΑ	
ICC		$V_{CC} = 5.5 \text{ V, I}_{O} = 0,$ $V_{I} = V_{CC} \text{ or GND}$	Outputs low		24	30		30		30	mA	
	_	11 100 01 0115	Outputs disabled		0.5	250		250		250	μΑ	
	Data	V _{CC} = 5.5 V, One input at 3.4 V,	Outputs enabled			1.5		1.5		1.5		
ΔI _{CC} §	inputs	Other inputs at V _{CC} or GND	Outputs disabled			0.05		0.05		0.05	mA	
	Control inputs	$V_{CC} = 5.5 \text{ V}$, One input at Other inputs at V_{CC} or GN				1.5		1.5		1.5		
Ci		V _I = 2.5 V or 0.5 V			4						pF	
Со		V _O = 2.5 V or 0.5 V			7.5						pF	

^{*} On products compliant to MIL-PRF-38535, this parameter does not apply.

[§] This is the increase in supply current for each input that is at the specified TTL voltage level rather than VCC or GND.



[†] All typical values are at $V_{CC} = 5 \text{ V}$.

[‡] Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

SN54ABT240, SN74ABT240A OCTAL BUFFERS/DRIVERS WITH 3-STATE OUTPUTS

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switching characteristics over recommended ranges of supply voltage and operating free-air temperature, C_L = 50 pF (unless otherwise noted) (see Figure 1)

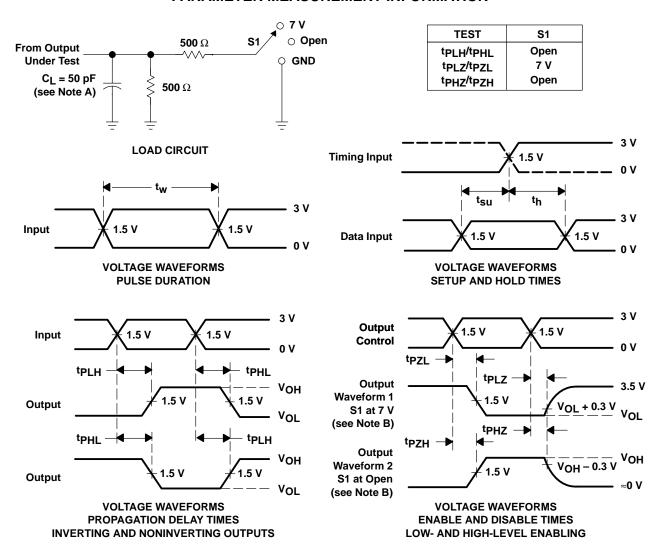
				SN	54ABT2	40		
PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _{CC} = 5 V, T _A = 25°C			MIN	MAX	UNIT
			MIN	TYP	MAX			
t _{PLH}	A	V	1	2.9	4.3	0.8	5.5	ns
^t PHL		ı.	1.6	3.1	4.5	1	5.5	115
^t PZH	ŌĒ	V	1.1	3.1	5.8	0.8	7.5	ns
tPZL		,	1.1	2.7	6.2	0.8	7.7	115
^t PHZ	ŌĒ	V	1.8	4.6	5.9	1.7	7	ns
^t PLZ		1	1.6	4	5.9	1.3	7.2	115

switching characteristics over recommended ranges of supply voltage and operating free-air temperature, C_L = 50 pF (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _{CC} = 5 V, T _A = 25°C			MIN	MAX	UNIT
			MIN	TYP	MAX			
^t PLH	А		1	2.9	4.1	1	4.8	no
^t PHL		ī	1.6	3.1	4.6	1.6	4.8	ns
^t PZH		V	1.1	3.1	4.7	1.1	5.2	ns
t _{PZL}	ŌĒ	ī	1.1	2.7	5.8	1.1	6.2	110
^t PHZ	ŌĒ	V	1.8	4.6	5.7	1.8	6.4	ns
^t PLZ		1	1.6	4	5.4	1.6	5.8	115



PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_O = 50~\Omega$, $t_f \leq$ 2.5 ns, $t_f \leq$ 2.5 ns.
- D. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms

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